Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/509,364	YAMASHITA, TOSHIHIKO	
Examiner	Art Unit	
HIEU T. VO	3747	

	SEARCHED					
Class	Subclass	Date	Examiner			
701	114 115 102	8/6/2005	VH			
73	116 117.3	8/6/2005	VH			
123	406.53	8/6/2005	VH			
	406.56	8/6/2005	VH			
	406.58	8/6/2005	VH			
			-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
All of above		8/7/2005	VH		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	8/7/2005	VH		
WEST	8/7/2005	VH		
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